

Source	Uncertainty
Integrated luminosity	0.6–2%
Pileup	1%
L1 prefiring	1%
p_T^{miss} trigger efficiency	1–2%
Single-electron trigger efficiency	1%
Muon isolation efficiency	1%
Muon identification efficiency	1%
Electron reconstruction efficiency	1%
Electron identification efficiency	2–3%
Tau veto	3%
Hadronic recoil U	5%
Jet energy corrections	4%
DEEPJET efficiency	Shape
DEEPAK15 efficiency	Shape
VV cross section	20%
$H \rightarrow b\bar{b}$ cross section	20%
DY+jets cross section	20%
Single t cross section	10%
$t\bar{t}$ cross section	10%
QCD- p_T^{miss} normalization	100%
QCD-electron normalization	100%
QCD-muon normalization	100%
Higher-order corrections	Shape
Bin-by-bin event counts	Shape